

**Search Notes**

Application/Control No.

10/753,976

Examiner

John F. Ramirez

Applicant(s)/Patent under  
Reexamination

LIEW ET AL.

Art Unit

3737

**SEARCHED**

Class	Subclass	Date	Examiner
UPDATED		11/29/2006	JFR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	11/29/2006	JFR